

Search Notes

Application/Control No.

10/525,683

Examiner

Ren L. Yan

Applicant(s)/Patent under
Reexamination

LORIG ET AL.

Art Unit

2854

SEARCHED

Class	Subclass	Date	Examiner
101	216 217	4/26/07	RY
	375		
	376		
	382.1		
	383		
above search updated		8/9/07	RY

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
101	376	8/9/07	RY
	382.1		

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR